



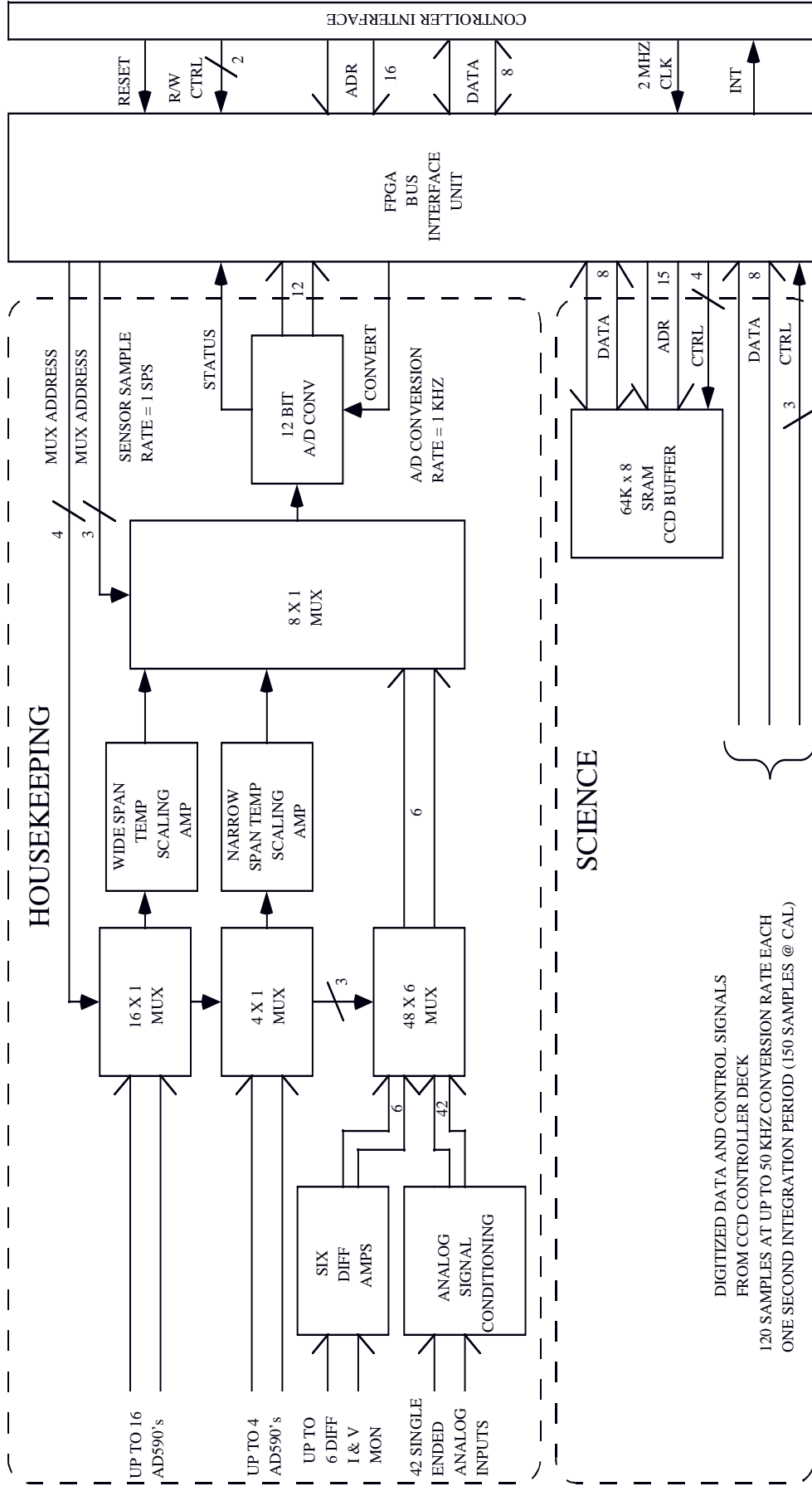
**TIDI**

# Data Acquisition Deck

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# DA Deck Block Diagram





# Telemetry Measurement Points

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- **Telescope Temps (4)**
  - Optics Housing\*
  - Pedestal Mount
  - LVDT Preamp
- **Profiler Temps**
  - Profiler base plate
  - Filter wheel housing\*
  - CCD Substrate\*
  - CCD Preamp
  - Sensor Window\*
  - Profiler Rod\*
  - Profiler Leaf\*
  - Profiler Post\*
- **Stack Temps**
  - PS Deck
  - Flight Computer Deck
  - Data Acquisition Deck
- **Spacecraft Interface**
  - Primary Voltage
  - Primary Instrument Current
  - Primary Op. Htr. Current
- **Telescope Position (4)**
  - Position
  - Position Error
- **Telescope Servo (4)**
  - Telescope holding current

\* Indicates Heater Control Point

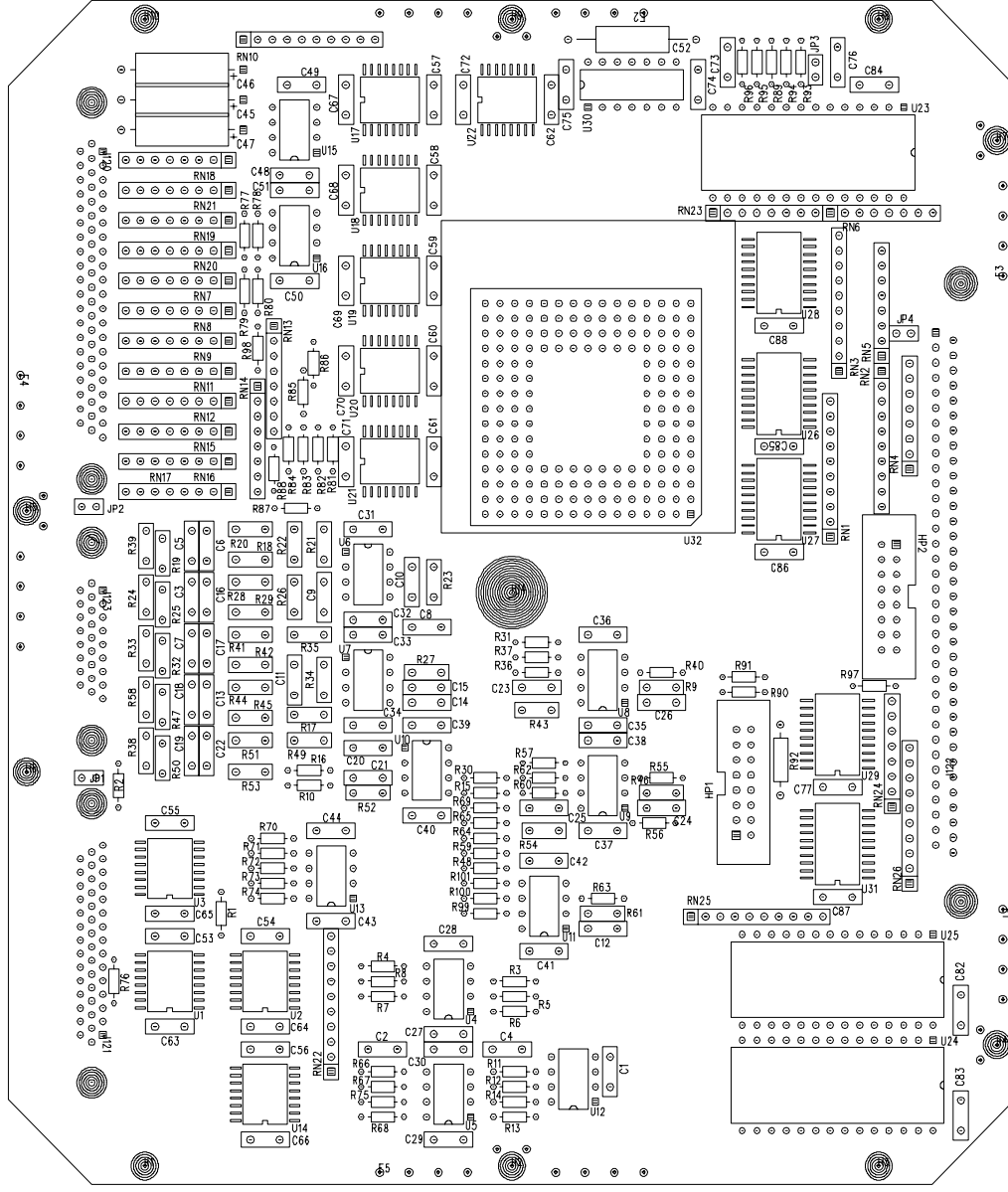


## Telemetry Measurement Points (contd)

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- **CCD Controller**
  - Drive Level D-A's (14)
- **Power Supply Secondary**
  - Voltages
    - +5, +15, -15, +6, -6, +26, +28
  - Currents
    - +6 Total Avg Servo Current
    - 6 Total Avg Servo Current
    - +28 Cal Lamp Total Current

# DA Deck PCB Layout



## Performance Requirements & Goals

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- **Maintain 1 Megohm Isolation for the 3 Spacecraft Primary current and voltage measurements**
    - Provided by 3 differential amplifiers, each having a common mode input impedance of 5 Megohms
  - **Filter critical measurements as close to Nyquist criteria as possible (Sensor sample rate = 1 Hz)**
    - 1 KHz burst rate multiplexing requires that all 1 Hz Nyquist filtering be performed at the input to the multiplexer
    - Reasonable physical size capacitance values limited to 0.1uF
    - Differential amplifiers for servo total current and S/C primary measurements will achieve 0.09Hz BW, 3 pole roll off
    - Other critical measurements are filtered at the source
- Telescope servo position errors are heavily filtered at the servo deck output



## Performance Requirements & Goals contd.

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- **Analog signal conditioning will not degrade temperature performance of A-D converter.**
  - Analysis of all interface circuits indicates less than 1 LSB error contribution to A-D conversion process
  - Specified absolute accuracy (combined span and zero) for Analog Devices AD674B converter is 7 LSB over full -55 to +125 C mil temperature range
  - Measurement of data acquisition board temperature at or near the A/D converter will be provided to permit calibration of systematic error
- **Provide 64K of SRAM buffer memory for the CCD data**



## Remaining Design Tasks

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- **Add 4 additional temperature monitors for telescopes**
- **Add internal temperature monitor near A/D**
- **Complete the FPGA design**
- **Derating Inspection and Calculations**
- **Update Software Interface Document**
- **Conduct internal final design review**